





	RF Exposure Evaluation			
Report Reference No::	LCSA02175044EB	IN THINK		
Date Of Issue :	March 28, 2025			
Testing Laboratory Name :	: Shenzhen LCS Compliance Testing Laboratory Ltd.			
Address:	101, 201 Bldg A & 301 Bldg C, Juji Industrial Park Shajing Street, Baoan District, Shenzhen, China			
Testing Location/ Procedure :	 Full application of Harmonised standards Partial application of Harmonised standards □ Other standard testing method □ 			
Applicant's Name: :	GCteq Wireless (Shenzhen) Co., Ltd.	可放到限份		
Address :	No. A402, Floor 4, Suojia Science parkCo Community, HangchengStreet, Bao'an, Di Guangdong Province, China			
Test Specification				
Standard :	FCC KDB publication 680106 D01 RF Exp Charging Apps v04 FCC CFR 47 part1 1.1310 FCC CFR 47 part2 2.1091	oosure Wireless		
	FCC CFR 47 part 18.107			
Test Report Form No:	A 1/10 12 12 12 12 12 12 12 12 12 12 12 12 12			
TRF Originator:	Shenzhen LCS Compliance Testing Labor	atory Ltd.		
Master TRF				
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· · · · · · · · · · · · · · · · · · ·	Embedded Multi-Functional Integrated	Cup Holder		
Trade Mark : Test Model :	$V(\mathbf{x}) = (\mathbf{x})^{-1}$			
Ratings :	Input: DC 24-36V,3A Output: USB-A: 18W Max; Type-C: 20W M A+C: 15W Max; Wireless Output: 15W Ma			
Result:	Positive			
Compiled by:	Supervised by:	Approved by:		
Joker. Hu	fack Liu	Jains Fiang		
Lift is in the Lift	resting Contesting	IS I Door		



RF Exposure Evaluation

SA02175044EB

March 28, 2025 Date of issue

Test Model	: GF-CH03AC		
EUT	: Embedded Multi-Functional Integrated Cup Holder		
Applicant	: GCteq Wireless (Shenzhen) Co., Ltd.		
Address	: No. A402, Floor 4, Suojia Science park Complex Sanwei Community, Hangcheng Street, Bao'an, District, Shenzhen City, Guangdong Province, China		
Telephone	:/		
Fax	: /		
Manufacturer	: GCteq Wireless (Shenzhen) Co., Ltd.		
Address	: No. A402, Floor 4, Suojia Science park Complex Sanwei Community, Hangcheng Street, Bao'an, District, Shenzhen City, Guangdong Province, China		
Telephone	: /		
Fax	: /		
Factory	: TEN PAO EIECTRONICS(HUIZHC)CoLTD.		
Address	: dongjiang indus trial Estate, shuikou Street, Huizhou City, Guangdong Province, P.R.C		
Telephone	: /		
Fax	:/ LCS Testing Lab		

Test Result	Positive	
Test Result	Positive	

The test report merely corresponds to the test sample.

It is not permitted to copy extracts of these test result without the written permission of the test laboratory.









Report Version	Issue Date	Revision Content	Revised By
000	March 28, 2025	Initial Issue	







行用检测器的

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1. Product Information

I. FIOUUCI IIIOIIIation			
Product Name	Embedded Multi-Functional In	tegrated Cup Holder	I I Mussing
Model Number	GF-CH03AC	- Bes Loo	- Bes Loo
Additional Model No.	GF-CH03BC		
Model Declaration	PCB board, structure and in additional models were tested	ternal of these model(s) are	the same, So no
Ratings	Input: DC 24-36V,3A		
	Output: USB-A: 18W Max; Typ	e-C: 20W Max	
	A+C: 15W Max; Wireless Outp	out: 15W Max	
Modulation Type	ASK		
Frequency Range	110.0~205.0KHz	后带	的品质
	360KHz		
Antenna Type	Coil Antenna	194	LCSTEST
Hardware version	1	have a second	
Software version	1		
Accessories	Phone*1		
Exposure category	General population/uncontrolle	ed environment	
EUT Type	Production Unit		
Device Type	Mobile Device		

2. Evaluation Method

Per KDB 680106 D01 Section 3. RF Exposure Requirements;

- 1) Wireless power transfer devices must comply with RF exposure requirements for all design configurations in which they can operate. At a minimum, RF exposure must be evaluated for the worst-case scenario, typically when the transmitter, while delivering energy to a client device, is operating at maximum output power. RF exposure compliance for equipment authorization must be determined following the guidance of KDB447498, which includes consideration of the different test requirements for *Mobile Device* and *Portable Device* exposure categories, as defined in §§ 2.1091 and 2.1093 of the Rules.
- 2) The RF exposure limits, as set forth in § 1.1310, do not cover the frequency range below 100 kHz for Specific Absorption Rate (SAR) and below 300 kHz for Maximum Permitted Exposure (MPE). In addition, present limitations of RF exposure evaluation systems prevent an accurate evaluation of SAR below 4 MHz. For these reasons, a specific MPE-based RF Exposure compliance procedure for devices operating in the aforementioned low-frequency ranges has been set in place. This procedure is applicable to Equipment Authorization of all RF devices, thus including, but not limited to, Part 18 and WPT devices. Accordingly, for § 2.1091-*Mobile* devices, the MPE limits between 100 kHz to 300 kHz are to be considered the same as those at 300 kHz in Table 1 of § 1.1310, that is, 614 V/m and 1.63 A/m, for the electric field and magnetic field, respectively. For § 2.1093-*Portable* devices below 4 MHz and down to 100 kHz, the MPE limits in § 1.1310 (with the 300 kHz limit applicable all the way down to 100 kHz) can be used for the purpose of equipment authorization in lieu of SAR evaluations.

Furthermore, consistent with FCC's equipment authorization RF exposure guidance, any device (both portable and mobile) operating at frequencies below 100 kHz is considered compliant for the purpose of equipment authorization when the external (unperturbed) temporal peak field strengths do not exceed the following reference levels:

83 V/m for the electric field strength (E)

and 90 A/m for the magnetic field strength (H)

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Report No.: LCSA02175044EB

These data may be provided through measurements and/or numerical simulations, and for all the positions in space relevant for any possible body exposure.

3) "Large size" probes may prevent the measurement of E- and/or H-fields near the surface of the radiating structure (e.g., a WPT source coil), as in the example shown in Figure 1.

If the center of the probe sensing element is located more than 5 mm from the probe outer surface, the field strengths need to be estimated through modeling for those positions that are not reachable. The estimates may be done either via numerical calculation, or via analytic model: e.g., approximated formulas for circular coils, dipoles, etc., may be acceptable if it is shown that the model is applicable for the design parameters considered. A typical example is the use of a quasi-static approximation formula for a low-frequency magnetic field source. These estimates shall include points spaced no more than 2 cm from each other. Thus, in the example of

Figure 1, at least the estimates at 0 cm2 and 2 cm are required, while only one point would not be sufficient. In addition, the model needs to be validated through the probe measurements for the two closest points to the device surface, and with 2-cm increments, as indicated in Figure 1. In that example, the same model must also be applied to the 4 cm and 6 cm positions, and then compared with the measured data, for validation purposes. The validation is considered sufficient if a 30% agreement between the model and the (E- and/or H-field) probe measurements is demonstrated. If such a level of agreement cannot be shown, a more accurate model (and/or a smaller probe) shall be used.

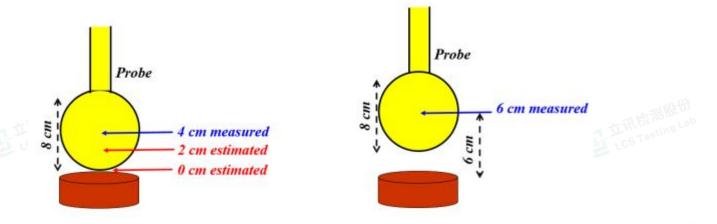
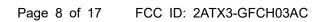


Figure 1. Example of probe (in yellow) measurements in points close to the WPT device (in red/brown). The probe radius is 4 cm, thus the closest point to the device where the field can be measured is at 4 cm from the surface (this example assumes that the probe calibration refers to the center of the sensing element structure, in this case a sphere of 4 cm radius). Data at 0 cm and 2 cm must be estimated through a model, and then the same model must be validated via comparison with the actual measurements at 4 cm and 6 cm, where the probe center can be positioned and collect valid data.

4) Part 18 Wireless Power Transfer up to One-Meter Distance. This section applies only to WPT transmitters that, by design, can provide power to a load located at a distance no greater than one meter. This distance shall be measured between the closest points between the transmitter and the receiver enclosure surfaces. For instance, two coils positioned as in Figure 2-a may be operated and considered under the provisions of this section, because both receivers are within one-meter distance from the transmitter. However, the case in Figure 2-b cannot be considered in the same way, and it is treated according to the prescription of Section 5.3.

For WPT designs with more than one radiating structure the distance to the load shall be considered as in Figure 3, thus measured between the receiver and the closest transmitting structure.





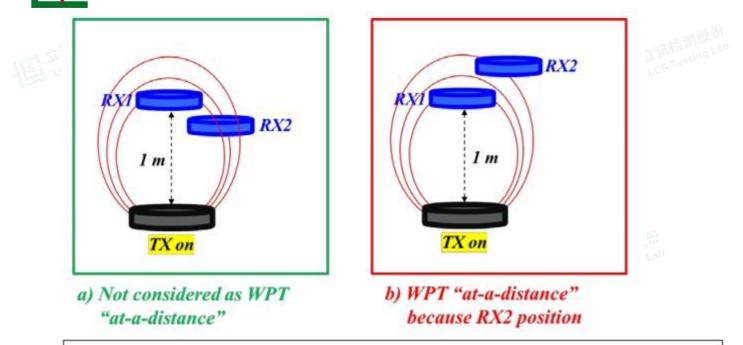


Figure 2-a) For multiple-receiver systems (here shown with two receivers, indicated with RX1 and RX2) the one-meter distance limit must apply for all the receivers that are engaged in the charging process. b) The WPT system is considered "at-a-distance" because it can function when the RX2 is further away than one meter from the transmitter.

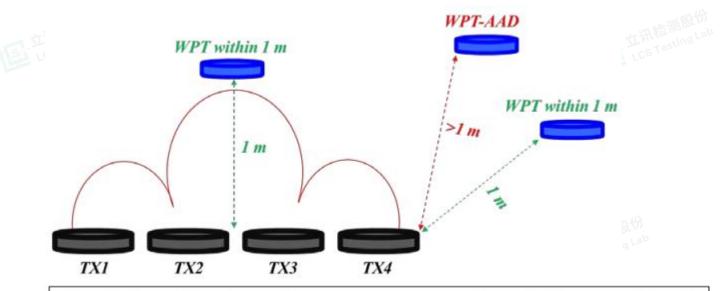


Figure 3. For multiple-coil transmitter systems, the one-meter distance limit is measured from the closest coil edge. A WPT within one meter operates with loads configured as those labeled in green font, if a load can be powered beyond one meter (in red), then it shall be considered "at-a-distance"

There might be situations where the WPT RF emissions are limited enough that even operations in a "crowded" environment, where many similar WPT devices are present, do not pose significant EMC and RF exposure concerns. In this scenario, and for devices operating within a one-meter distance from the receiver, as defined above, a manufacturer will not have to submit an "Equipment Compliance Review" KDB, and receive FCC concurrence before proceeding with equipment authorization. This exception to the requirement of submitting the ECR to obtain FCC concurrence only applies when all the following criteria (1) through (6) are met:





- (1) The power transfer frequency is below 1 MHz.
- (2) The output power from each transmitting element (e.g., coil) is less than or equal to 15 watts.
- (3) A client device providing the maximum permitted load is placed in physical contact with the transmitter (i.e., the surfaces of the transmitter and client device enclosures need to be in physical contact)
- (4) Only § 2.1091- Mobile exposure conditions apply (i.e., this provision does not cover § 2.1093 Portable exposure conditions).
- (5) The E-field and H-field strengths, at and beyond 20 cm surrounding the device surface, are demonstrated to be less than 50% of the applicable MPE limit, per KDB 447498, Table 1. These measurements shall be taken along the principal axes of the device, with one axis oriented along the direction of the estimated maximum field strength, and for three points per axis or until a 1/d (inverse distance from the emitter structure) field strength decay is observed. Symmetry considerations may be used for test reduction purposes. The device shall be operated in documented worst-case compliance scenarios (i.e., the ones that lead to the maximum field components), and while all the radiating structures (e.g., coils or antennas) that by design can simultaneously transmit are energized at their nominal maximum power.
- 5) For systems with more than one radiating structure, the conditions specified in (5) must be met when the system is fully loaded (i.e., clients absorbing maximum power available), and with all the radiating structures operating at maximum power at the same time, as per design conditions. If the design allows one or more radiating structures to be powered at a higher level while other radiating structures are not powered, then those cases must be tested as well. For instance, a device may use three RF coils powered at 5 W, or one coil powered at 15 W: in this case, both scenarios shall be tested

3. Evaluation Limit

3. 1 Refer Evaluation Method

ANSI C95.1–1999: IEEE Standard for Safety Levels with Respect to Human Exposure to Radio Frequency Electromagnetic Fields, 3 kHz to 300 GHz.

<u>FCC KDB publication 680106 D01 RF Exposure Wireless Charging Apps v04:</u> RF Exposure Considerations for Low Power Consumer Wireless Power Transfer Applications <u>FCC CFR 47 part1 1.1310</u>: Radiofrequency radiation exposure limits. <u>FCC CFR 47 part2 2.1091</u>: Radiofrequency radiation exposure evaluation: mobile devices FCC CFR 47 part 18.107:Indusial, Scientific, and Medical Equipment

3.2 Limit

Limits for Maximum Permissible Exposure (MPE)/Controlled Exposure

Frequency	Electric Field	Magnetic Field	Power Density	Averaging Time
Range(MHz)	Strength(V/m)	Strength(A/m) (mW/cm ²)		(minute)
	Limits for Oc	ccupational/Controlle	ed Exposure	
0.3-3.0	614	1.63	*100	6
3.0-30	1842/f	4.89/f	*900/f ²	6
30-300	61.4	0.163	1.0	6
300-1,500	人而限份	/	f/300	6
1,500-100,000	Till Pesting Lab		Testing 5	6
,	LET LC2	Ven re	D 1	Med res





LCS Testing Lab

Limits for Maximum	Permissible Exposu	ire (MPE)/Uncontroll	ed Exposure	VIST CS Testin
Frequency	Electric Field	Magnetic Field	Power Density	Averaging Time
Range(MHz)	Strength(V/m)	Strength(A/m)	(mW/cm²)	(minute)
	Limits for Genera	al Population/Uncon	trolled Exposure	
0.3-1.34	614	1.63	*100	30
1.34-30	824/f	2.19/f	*180/f ²	30
30-300	27.5	0.073	0.2	30
300-1,500	/	1	f/1500	30
1,500-100,000	/	12 13	1.0	30
		THE MELAD	t.	Lift har ing Lab

1 Ballen Com Maximum Darminsible Expedure (MDE)// Incontrolled

F=frequency in MHz

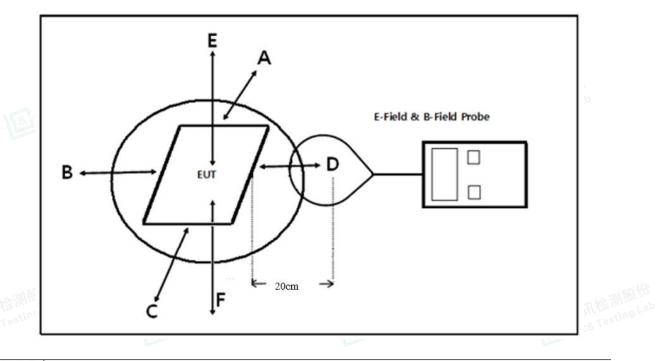
LCS Testing Lab *=Plane-wave equivalent power density

According to FCC KDB 680106 D01 Section 3. RF Exposure Requirements clause 3 the Emission-Limits in the frequency range from 100 KHz to 300 KHz should be assessed versus the limits at 300 KHz in Table 1 of CFR 47 - Section 1.310 as following (measured distance shall be 20cm from the center of the probe to the edge of the device):

	E-Field	*/*	B-Field
Frequency	V/m	A/m	uT
0.3 MHz – 3.0 MHz 614		1.613	2.0
3.0 MHz – 30 MHz	824/f (=27.5 _{30MHz})	2.19/f (=0.073 _{30MHz})	T With Testing
N 9. 371	102		

A KDB inquire was required to determine/confirm the applicable limits below 100 KHz.

4. Test Setup Diagram





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5. Test Equipment

Equipment	Manufacturer	Model	Serial no.	Calibrated date	Calibrated Due
Exposure Level Tester	Narda	ELT-400	N-0713	2024-11-11	2025-11-10
B-Field Probe	Narda	ELT-400	M-1154	2024-10-08	2025-10-07
Electric field probe	Narda	EP601	611WX70332	N/A	N/A

6.Support equipment List

Manufacturer	Description	Model	Serial Number	Certificate
Trimble Electronics Co., LTD	Power Adapter	S058AAC29 00200	-	FCC
Huawei	Mobile phone	FRD-AL10	FRD-AL10C00B 373	FCC

Note: Auxiliary equipment is provided by the laboratory and only use tested.

7. Measurement Procedure

a) The RF exposure test was performed on 360 degree turn table in anechoic chamber.

b) The measurement probe was placed at test distance (20cm) which is between the edges of the charger and the geometric center of probe.

c) The turn table was rotated 360d degree to search of highest strength.

d) The highest emission level was recorded and compared with limit as soon as measurement of each points (A, B, C, D, E) were completed.

e) The EUT were measured according to the dictates of KDB 680106 D01v04.





8. Equipment Approval Considerations

The EUT does comply with item 5.2 of KDB 680106 D01v04 as follows table;

Requirements of KDB 680106 D01	Yes / No	Description	
Power transfer frequency is less than 1 MHz	Yes	The device operates in the frequency range 110.0 KHz - 205 KHz,360Khz	
The output power from each transmitting element (e.g., coil) is less than or equal to 15 watts.	Yes	The maximum output power of the primary coil is 15W.	
A client device providing the maximum permitted load is placed in physical contact with the transmitter (i.e., the surfaces of the transmitter and client device enclosures need to be in physical contact)	Yes	Client device is placed directly in contact with the transmitter.	
Only § 2.1091- Mobile exposure conditions apply (i.e., this provision does not cover § 2.1093-Portable exposure conditions). The E-field and H-field strengths, at and beyond 20 cm surrounding the device surface, are demonstrated to be less than 50% of the applicable MPE limit, per KDB 447498, Table 1. These measurements shall be taken along the principal axes of the device, with one axis oriented along the direction of the estimated maximum field strength, and for three points per axis or until a 1/d (inverse distance from the emitter structure) field strength decay is observed. Symmetry considerations may be used for test reduction purposes. The device shall be operated in documented worst-case compliance scenarios (i.e., the ones that lead to the maximum field components), and while all the radiating structures (e.g., coils or antennas) that by design can simultaneously transmit are energized at their nominal maximum power. For systems with more than one radiating structure, the conditions specified in (5) must be met when the system is fully loaded (i.e., clients absorbing maximum power available), and with all the radiating structures operating at maximum power at the same time, as per design conditions. If the design allows one or more radiating structures to be powered at a higher level while other radiating structures are not powered, then those cases must be tested as well.		Mobile exposure conditions only	
		The EUT H-field strengths at 20 cm all simultaneous transmitting coils are demonstrated to be less than 50% of the MPE limit.	
		Only one radiating structure and tested at maximum Output Power	



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For instance, a device may use three RF coils powered at 5 W, or one coil powered at 15 W: in this case, both scenarios shall be tested



There might be situations where the WPT RF emissions are limited enough that even operations in a "crowded" environment, where many similar WPT devices are present, do not pose significant EMC and RF exposure concerns. In this scenario, and for devices operating within a one-meter distance from the receiver, as defined above, a manufacturer will not have to submit an "Equipment Compliance Review" KDB, and receive FCC concurrence before proceeding with equipment authorization. This exception to the requirement of submitting the ECR to obtain FCC concurrence only applies when all the following criteria (1) through (6) are met.

9. E and H field Strength

Test Modes						
Mode 1	AC/DC Adapter(36V)+EUT+mobile phone (Battery Status: <1%)	Record				
Mode 2	AC/DC Adapter(36V)+EUT+mobile phone (Battery Status: <50%)	Pre-tested				
Mode 3	AC/DC Adapter(36V)+EUT+mobile phone (Battery Status: 100%)	Pre-tested				
Mode 4	AC/DC Adapter(24V)+EUT+mobile phone (Battery Status: <1%)	Pre-tested				
Mode 5	AC/DC Adapter(24V)+EUT+mobile phone (Battery Status: <50%)	Pre-tested				
Mode 6	AC/DC Adapter(24V)+EUT+mobile phone (Battery Status: 100%)	Pre-tested				

Note: All test modes were pre-tested, but we only recorded the worst case in this report.

Measured Field Strength Values Frequency Range Field Load mode 50% Limits Limits (kHz) Strength Test Position E Mode 1 uΤ 110.0~205.0 0.146 ------A/m Mode 1 110.0~205.0 0.117 0.815 1.63 V/m Mode 1 110.0~205.0 43.946 307 614 Mode 2 110.0~205.0 uT 0.146 ---___ Mode 2 A/m 110.0~205.0 0.117 0.815 1.63 Mode 2 110.0~205.0 V/m 43.845 307 614 Mode 3 uΤ 110.0~205.0 0.144 ----Mode 3 110.0~205.0 A/m 0.115 0.815 1.63 V/m Mode 3 110.0~205.0 43.374 307 614

Field Strength at 20 cm from the edges surrounding the EUT and 20cm from the top surface of the EUT



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Scan code to check authenticity



Load		Frequency Range	Field	Measured Field Strength Values	500/11 11		
	Load mode	(kHz)	Strength	Test	- 50% Limits	Limits	
				Position E			
	Mode 1	360	uT	0.144			
	Mode 1	360	A/m	0.115	0.815	1.63	
	Mode 1	360	V/m	43.258	307	614	
	Mode 2	360	uT	0.142			
	Mode 2	360	A/m	0.114	0.815	1.63	
	Mode 2	360	V/m	42.774	307	614	
	Mode 3	360	uT	0.144	THE THE	TestingLap	
	Mode 3	360	A/m	0.116	0.815	1.63	
	Mode 3	360	V/m	43.436	307	614	

Note:V/m=10(((20lg(A/m*10^6)+51.5)-120)/20) Note:A/m=uT/1.25







(TM1)

<u>1-2 3 4 5 6 7 8 9 10 11 12 13 4 15 16 17 18 19 20 21 22 23 4 25 56 77 56 30 31 22 33 4 35 56 57 56 340 4 6 66 4 45 66</u>

10.2.Test Position B - Exposure photo from side edge surface-Left(20cm)





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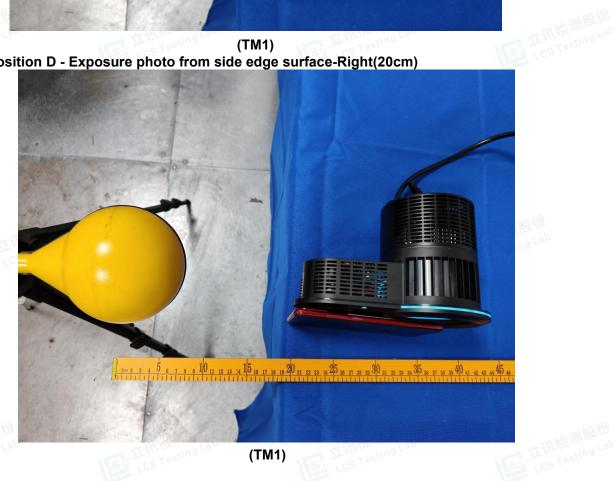
(TM1)





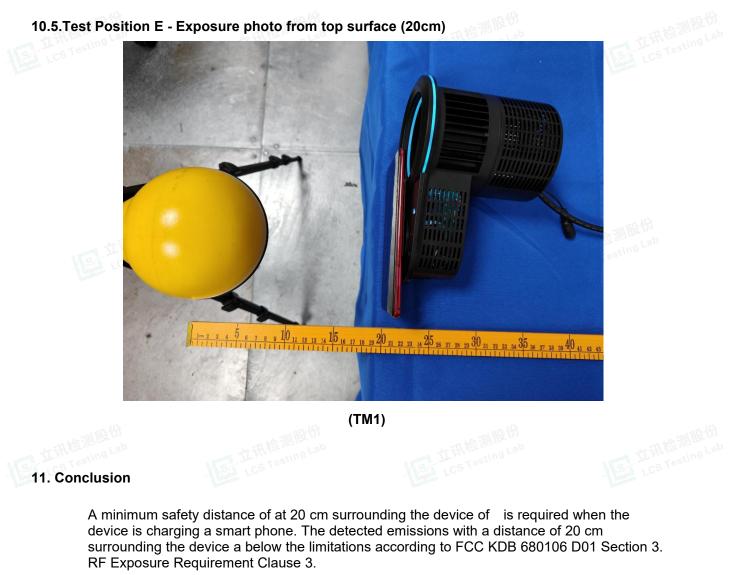


(TM1) 10.4.Test Position D - Exposure photo from side edge surface-Right(20cm)









12. Description of Test Facility

NVLAP Accreditation Code is 600167-0.

FCC Designation Number is CN5024

CAB identifier is CN0071.

CNAS Registration Number is L4595.

Test Firm Registration Number: 254912.



.....END OF REPORT.....

